

Notice of References Cited

Application/Control No.

10/634,667

Applicant(s)/Patent Under
Reexamination
BABICH ET AL

Examiner

Amanda C Walke

Art Unit

1752

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,877,080	03-1999	Aoi et al.	438/622
	B	US-6,767,930	07-2004	Svejda et al.	521/134
	C	US-6,569,932	05-2003	Hsiao et al.	524/269
	D	US-4,626,556	12-1986	Nozue et al.	522/99
	E	US-2004/0067633	04-2004	Tsai et al.	438/622
	F	US-6,100,417	08-2000	Lichtenhan et al.	556/460
	G	US-6,517,958	02-2003	Sellinger et al.	428/690
	H	US-6,759,460	07-2004	Kamo et al.	524/100
	I	US-6,344,305	02-2002	Lin et al.	430/270.1
	J	US-6,660,823	12-2003	Lichtenhan et al.	528/37
	K	US-6,187,505	02-2001	Lin et al.	430/270.1
	L	US-6,664,024	12-2003	Nguyen et al.	430/280.1
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.